SUBSTITUTE FORM PTO-1449 (MODIFIED) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSUKE MAIL STATEMENT BY APPLICATION (Use several sheets if necessary)										IT OF COMMERCE ADEMARK OFFICE	ATTY. DOCKET NO. 03375/003003 SERIAL NO. 08/403,277						
	;	INFC STAT	ORM/ FEMI	AT I	ON 1	DIS AP	CLO PLI	suk	MAILAC	8	APPLICANT Kristoph D. Krug et al.						
(Use several sheets if necessary) (37 CFR 1.98(b))											FILING DATE March 13, 1995	GROUP 2411					
								10	کی د	U.S. PATEN	T DOCUMENTS		_				
EXAMINER									SOFMARK OF	/		T		FILING DATE			
INITIAL			P/	ATE	NT I	NUM	BER		DATE	PATENTEE CLASS			SUBCLASS	IF APPROPRIATE			
19/1	AA	3	6	7	8	2	7	8	07/08/1972	Peil		4					
M	AB	3	8	3	2	5	4	5	08/27/1974	Bartko		<u>;</u>					
NIP	AC	3	8	4	8	1	3	0	11/12/1974	Mocovski		-					
214	AD	3	9.	1	9	4	6	7	11/11/1975	Peugeot		-		. /			
SA	AE	3	9	2	4	0	6	4	12/02/1975	Nomura et al.	,						
MP	AF	3	9	4	4	8	3	0	03/16/1976	Dissing							
	AG	3	9	9	6	4	7	1	12/07/1976	Fletcher				_ /			
AM	AH	4	0	2	0	3	4	6	04/26/1977								
3/2	AI	4,	o	2	9	9	6	3	06/14/1977								
JAP .	AJ	4	0	4	7	ó	3	5	09/06/19 7 7								
Diff	AK/	4	1	3	9	7	7	1	02/13//1979	Dennhoven et	al. /		-				
DAP	χL	4	2	1/	0	8	1	1	07/0/1/1980	/01/1980 Dennhoven et al. /							
JAP)	AM	4	2	4	6	4	9	9	08/05/1980	Kunze et al.			-//				
M	AN	4	3	6	6	3	8	2	12/28/1982	Kotowski							
IN.	AO	4	4	5	4	6	0	5	06/12/1984	DeLucia							
	AP	4	5	5 3 0 0 0 6 07/16/1985 Blaustein et al.									_/_				
1					0	THE	R D	OCU	MENTS (Includ	ding Author, Ti	tle, Date, Place of Public	ation)					
Mo			L	ehm	ann	et	al	٠,	"Generalized	Image Combinat	ions in Dual KVE Digital Ra	adiography"	ography" Medical Physics, Vol. 8,				
DH	AQ		No. 5, p. 659, Sep./Oct. 1981.														
6.0			Si	Sartoris et al., "Bone Mineral Density in the Femoral Neck", American Journal of Roentegenology, Vol. 144,													
AH	AR		p	. 6	05	(19	85)	•						· · · · · · · ·			
	40		G	Gustafsson et al., "X-ray Spectrophotometry for Bone-Mineral Determinations", Medical and Biomedical													
MA	AS		E	Engineering, p.113 (Jan. 1974).													
\\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\	AT		T	Can	n,	"A	Cli	nic	ians Guide to	the Use of Bo	ne Mass Measurements", page	= 12 fai	le uni	krown			
	AT			,													
Ann	AU		W	Wehner et al., "Non-Invasive Bone Mineral Measurements", Seminars in Nuclear Medicine, Vol. XIII, No. 3,													
NP			p	. 2	82,	Ju	ι.	198	3.								
M	AV		Di	unn	et	al	٠,	"Me	asurement of	Bone Mineral Co	ontent in Human Vertebrae	nd Hip by D	ual Proton	Absorptiometry",			
			R	adi	olo	gy,	٧o	١.	136, No. 2, p	o. 485 (Aug. 198	80).						
EXAMINE	R		R	Ø.	T N			[DATE CONSIDERED						
									ed. Draw lir o applicant.	ne through cita	tion if not in conformance	and not con	sidered.	Include copy of			

1

SUBSTITUTE FORM PTO-1449 (MODIFIED)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 03375/003003

SERIAL NO. 08/403,277

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary) APPLICANT Kristoph D. Krug et al.

FILING DATE

GROUP 2411

(37 CFR 1	7 CFR 1.98(b)) March 13, 1995 2411										2411				
										U.S. PATENT DOCUMENTS					
XAMINER INITIAL			P	ATE	NT	NUM	BER		ISSUE PATENTEE CL			SUBCLASS	FILING DATE IF APPROPRIATE		
	BA	4	5	3	9	6	4	8	09/03/1985	Schatzki					
12/1	ВВ	4	5	6	6	1	1	3	01/21/1986	/1986 Donges et al.					
	BC	4	6	3	9	9	4	3	01/27/1987	Heinze et al.		_			
DD.	BD	4	6	4	1	3	3	1	02/03/1987	Makino et al.					
D	BE	4	6	4	4	5	7	8	02/17/1987	Paolini ,					
AH)	BF	R	Ε	2	8	5	4	4	09/02/1975	Stein et al					
SP	BG	4	7	3	6	4	0	1	04/05/1988	Donges et al.					
M.	ВН	4	7	5	6	0	1	5	07/05/1988	Doenges et al.					
DH	BI	4	7	5	9	0	4	7	07/19/1988	Donges et al.			- 1/		
(IA)	ВЈ	4	7	8	3/	7	9	4	11/08/j1988	Dietrich	- /				
PH	BK	4	7	8	8	7	0	5	11/29/1988	Donges et al.			· · ·		
BII	BL	4	8	1	7	1	2	1	03/j28/1989	Shimizu et al.	1				
AM	BM	4	8	4	1	5	5	4	06/20/1989	Doenges et al.					
Diff	BN	4	8/	7	0	6	7	0	09/26/1989	Geus					
NAN)	80	4	8	7	9	7	3	5	11/07/1989	Owens					
					0	THE	R D	ocu	MENTS (Includ	ling Author, Title, Date, Place of Publica	tion)				
Van	ВР			The	ыN	orl	and	Di	chromatic Bor	me Densitometer" pamphlet	onka	own.			
1011		_	\perp												
DAD	BQ			Bos	ton	Gl	obe	ar	ticle, "U.S.	Says American Airlines Has Poor Security	Record", da	ted Feb. 18	3. 1989.		
	·														
AM) Br		Alvarez et al., "Characterization of the X-Ray Attenuation Properties of Explosives and Their Implications												
				in	Bag	gag	e S	cre	ening", Repor	t No. FAA-RD-79-50, Mar. 1979.					
M	BS	EG&G Astrophysics brochures. Lake Unkanun													
1/0		1	†	Sca	n-t	ech	Sec	cur	ity brochure.	date anterior		1			
OF	BT		T		_		مر			- Company					
EXAMINE	R	1	N		1		J L	þ	H	DATE CONSIDERED	6		· · · · · · · · · · · · · · · · · · ·		
EXAMINER:	Init	iel ne	ci	tat com	ion	z6i ica	nsic tio	der	ed. Draw lir o applicant.	e through citation if not in conformance	and not con	sidered. 1	include copy of		

FILING DATE

SUBSTITUTE FORM PTO-1449 (MODIFIED)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ISSUE

ATTY. DOCKET NO. 03375/003003

SERIAL NO. 08/403,277

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)

this form with next communication to applicant.

APPLICANT Kristoph D. Krug et al.

(37 CFR 1.98(b))

EXAMINER

FILING DATE March 13, 1995 **GROUP** 2411

U.S. PATENT DOCUMENTS

EXAMINER INITIAL			PATENT NUMBER						DATE	PATENTEE	CLASS	SUBCLASS	IF APPROPRIATE	
dell	CA	4	8	8	4	2	8	9	11/28/1989	Glockmann et al.			//	
M	СВ	3	8	4	0	7	4	7	10/1974	Macovski				
SM.	СС	4	4	6	3	3	7	5	07/1984	Macovski	\			
SHI	æ	4	5	4	9	3	0	7	10/1985	Macovski				
SB	CE	4	5	7	8	8	0	3	03/1986	Macovski				
DP	CF	4/	6	8	6	6	9	5	08/1987	Macovski				
SID	cg/	4	8	2	7	5	ź	8	05/1989	Macovski //	,			
SIA	CH	4.	2.	4	7	7'	7	4	01/1981/	Brooks #		<u>.</u>	/	
BBO 1	CI	4	7	4	8/	6	4	9	05/1988	Griesmet et al.				
SH	CJ	4	9	8	ó	9	2	3	12/1990	Kawamolo et al			<i>g</i>	
990	CK	5	1	3/	3	0	2	0	07/1992	Giger et al	1	- AP		
	CL	3	8	8	4	8	1	6	Ő5/1975	Krug et øl.				
	CM	4	8	5	1	9	8	4	07/1989	Doi et al.				
TH	CN	4	9	8	7	5	8	4	01/1991	Doenges				
(-		_			0	THE	R D	ocu	MENTS (Includ	ling Author, Title, Date, Place of Publicat	ion)			
JA'	CO	Hall et al., "Experimental system for dual energy scanned projection radiography", SPIE, Vol. 314,												
1// -				Digital Radiography (1981) pp. 155-159.										
Apr	СР			Hei	man	n S	yst	ems	Co. brochure	es, 1989.				
25/		L	\perp											
M	CQ		\perp	Bisignani et al., "Automated X-Ray Bomb Detection Techniques", 8079 Electro Conference Record, Vol. 4,										
WHAT			1	Paper 18/3 (1979).										
MA	CR	L		Ste	fan	ski	et	al	., "An X-Ray	Inspection System For Security Screening A	Application	Proceedi	ngs 1977	
MALL				Int	ern	ati	ona	l C	onference on	Crime Countermeasures - Science and Engine	ering, Ju	ly 25-29, 19	77, pp. 57-64.	
MA	CS	L	Ľ	Ric	har	d G	. C	umi	ngs, "A Surve	ey of X-Ray Technology and Available System	s for Parc	el Inspecti	on", Proceedings	
		Ļ	1	997	9 C	arn 2	aha	n C	onference on	Crime Countermeasures, May 16-18, 1979, pp	. 117-122.			
EXAMINE	R . ,	1	/	/	/			2		DATE CONSIDERED	///			
FYAMINED.	nit	ر اه ا		te+	ion		ne i	der	ed Drau lie	me through citation if not in conformance a	nd net co	sidered I	nclude conv of	

Substitute Disclosure Form (PTO-1449)

ş: 1	١ ٠											<u>_</u>			
** ,	<u></u>											Si		(D) of <u>4</u>	
SUBSTITUT (MODIFIED		M P	TO-	1449	9					NT OF COMMERCE ADEMARK OFFICE	ATTY. DOCKET NO. 03375/003003	SERIAL NO. 08/403,277			
		STA	TEM	ENT	BY	API	CLOS PLIC	CAN	T	!	APPLICANT Kristoph D. Krug et al.				
(37 CFR 1	-		era	l Si	hee	ts 1	17 1	nec	essary)	!	FILING DATE March 13, 1995		GROUP 2411		
									-	U.S. PATEN	T DOCUMENTS				
EXAMINER INITIAL			P.	ATE	NT I	NUME	BER	:	I SSUE DATE		PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
AM	DA	4	0	7	0	5	8	1	01/24/1978	Gibbons et al.	. /	250	455 T		
400	DB	5	0 .	2	2	0	6	2	06/1991	Annis		378	86		
Mal	DC	4	1	3.	8		1 - !	1	02/06/1979	Boyd	/			,	
DI	DD	3	9	2	4	1	2/	9	12/02/1975/	LeMay					
SIII	DE	4/	0	7	5	4/	·	2	02/21/1978	Boyd et al.		/_	A -		
SP.	DF /	4	2	5	5/	6	6	4	03/1981	Rutt et al.	/	250	445 T	4	
M	DG	5	0	3	ń	2	2	6	07/1991	Delange		382	22	k	
	р́н														
	DI														
FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION															
			noc	IME	NT	NUME	RER	,	PUBLICATION DATE		COUNTRY OR			TRANSLATION	
									57		PATENT OFFICE	CLASS	SUBCLASS	YES NO	
	DJ														
	DK					_									
A	DL														
ł	DM						_								
•					0.	THE	R D	ocu	MENTS (Inclu	ding Author, Ti	tle, Date, Place of Public	cation)			
		Τ	Т												
	DN	\vdash	+												
		${\dagger}$	十												
	DO	\vdash	+											·	
			+						***************************************	i					
	DP	\vdash	\dagger												
EXAMINE	ER .		Ť,	4 1 1		1	 F	1	AL		DATE CONSIDERED	12/8/			
EXAMINER:	: Unit n with	ial ne:	ci xt	tat com	ion mun	cor	nsic tio	der n t	ed. Draw lin o applicant.	ne through citat	tion if not in conformance	and not con	nsidered. 1	Include copy of	

Substitute Disclosure Form (PTO-1449)

141705.B11